Notice of References Cited Application/Control No. 10/696,933 Applicant(s)/Patent Under Reexamination BITSCH, RENE Examiner Anh Ly Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,006,225	12-1999	Bowman et al.	707/5
*	В	US-2002/0193986	12-2002	Schirris, Alphonsus Albertus	704/8
*	С	US-2005/0071324	03-2005	Bitsch et al.	707/003
*	D	US-2003/0101046	05-2003	Krasnov, Mark 704	
*	Ε	US-2002/0156770	10-2002	Krichilsky et al.	707/3
*	F	US-2006/0224995	10-2006	Treibach-Heck`et al.	707/003
*	G	US-2004/0230328	11-2004	Armstrong et al.	707/104.1
*	Н	US-2004/0243572	12-2004	Muto, Shin ·	707/003
*	1	US-2005/0267787	12-2005	Rose et al.	705/005
	J	US-			
	K	US-			
	L	US-			
	М	US-		·	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α	•				
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	w	
	X	s reference is not being furnished with this Office and the CO. MOSTO 207 05 (1)

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.